



IPC J-STD-004B with Amendment 1

Requirements for Soldering Fluxes

A standard developed by the Flux Specifications Task Group (5-24a)
of the Assembly and Joining Processes Committee (5-20) of IPC

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Users of this publication are encouraged to participate in the
development of future revisions.

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Requirements for Soldering Fluxes

1 SCOPE AND DESIGNATION

1.1 Scope This standard prescribes general requirements for the classification and characterization of fluxes for high quality solder interconnections. This standard may be used for quality control and procurement purposes.

1.2 Purpose The purpose of this standard is to classify and characterize tin/lead and lead-free soldering flux materials for use in electronic metallurgical interconnections for printed circuit board assembly. Soldering flux materials include the following: liquid flux, paste flux, solder paste, solder cream as well as flux-coated and flux-cored solder wires and preforms. It is not the intent of this standard to exclude any acceptable flux or soldering material; however, these materials must produce the desired electrical and metallurgical interconnection.

The requirements for fluxes are defined in general terms for standard classification. Appendix B has additional information that will help users understand some of the requirements of this standard. In practice, where more stringent requirements are necessary or other manufacturing processes are used, the user **shall** define these as additional requirements.

1.3 Designation For ordering purposes and designation by other specifications, the following flux identification system **shall** be used (see Table 1-1).

Table 1-1 Flux Identification System

Flux Composition	Flux/Flux Residue Activity Levels	% Halide ¹ (by weight)	Flux Type ²	Flux Designator
Rosin (RO)	Low	<0.05%	L0	ROL0
		<0.5%	L1	ROL1
	Moderate	<0.05%	M0	ROM0
		0.5-2.0%	M1	ROM1
	High	<0.05%	H0	ROH0
		>2.0%	H1	ROH1
Resin (RE)	Low	<0.05%	L0	REL0
		<0.5%	L1	REL1
	Moderate	<0.05%	M0	REM0
		0.5-2.0%	M1	REM1
	High	<0.05%	H0	REH0
		>2.0%	H1	REH1
Organic (OR)	Low	<0.05%	L0	ORL0
		<0.5%	L1	ORL1
	Moderate	<0.05%	M0	ORM0
		0.5-2.0%	M1	ORM1
	High	<0.05%	H0	ORH0
		>2.0%	H1	ORH1
Inorganic (IN)	Low	<0.05%	L0	INL0
		<0.5%	L1	INL1
	Moderate	<0.05%	M0	INM0
		0.5-2.0%	M1	INM1
	High	<0.05%	H0	INH0
		>2.0%	H1	INH1

1. Halide measuring <0.05% by weight in flux solids may be known as halide-free. This method determines the amount of halide present (see Appendix B-10).

2. The 0 and 1 indicate the absence or presence of halides, respectively. See paragraph 3.3.1.2.2 for flux type nomenclature.